Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/701,476	FUJITA ET AL.
Examiner	Art Unit

Thanhha Pham

2813

SEARCHED				
Class	Subclass	Date	Examiner	
438	622	12/7/2004	TSP	
	619	Î		
	623-640			
	672			
	675	,	/_	
J	687-688	7	4	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	
_			
:			

SEARCH NO (INCLUDING SEARC))
	DATE	EXMR
East (see attachment)	12/7/2004	TSP
IEEE	12/8/2004	TSP